

<b>Notice of References Cited</b>	Application/Control No. 10/523,745		Applicant(s)/Patent Under Reexamination MASCARENHAS ET AL.	
	Examiner THANH-TRUC TRINH		Art Unit 1795	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-4,133,698	01-1979	Chiang et al.	136/255
*	C	US-6,340,788	01-2002	King et al.	136/261
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	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Li et al., "A new thin-film humidity and thermal micro-sensor with Al/SrNb <sub>x</sub> Ti <sub>1-x</sub> O <sub>3</sub> /SiO <sub>2</sub> /Si structure", Sensors and Actuators, volume 75 (1999), pages 70-74
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.